BGR405 NPN Silicon RF Transistor With Bias Circuitry

Small Signal Discretes



Never stop thinking

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BGR405, NPN Silicon RF Transistor With Bias Circuitry

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Page	Subjects (major changes since last revision)
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NPN Silicon RF Transistor With Bias Circuitry*

1 NPN Silicon RF Transistor With Bias Circuitry*

Features

- Noise figure NF = 1.0 dB at 0.4 GHz
- Gain S₂₁ = 7.5 dB at 0.4 GHz
- On chip bias circuitry, 0.85 mA bias current at V_{CC} = 1.2 V
- SIEGET ® 25 GHz f_{T} -Line
- Pb-free (RoHS compliant) package
- * Short term description



Applications

LNAs

2 Description

The BGR405 is a monolithic silicon amplifier with a NPN silicon RF transistor and integrated resistors for biasing.

Туре	Package	Marking
BGR405	SOT343	AVs

Note: ESD (Electrostatic discharge) sensitive device, observe handling precaution!





Note: Due to design there is an additional diode between emitter and collector, which does not effect normal operation for common emitter configuration.

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Description

Table 1	Pinning table	
Pin	Function	
1	RFIN	
2	GND	
3	RFOUT	
4	VCC	

2.1 Maximum Ratings

Note: All Voltages refer to GND-node

Table 2Maximum ratings

Parameter	Symbol	Value	Unit
Current at pin VCC	I _{CC}	12	mA
Voltage at pin VCC	V _{cc}	5	V
Current at pin RFIN	I _B	0.8	mA
Voltage at pin RFIN	V _B	2	V
Current at pin RFOUT ¹⁾	I _{OUT}	12	mA
Voltage at pin RFOUT	V _{OUT}	4.1	V
Total power dissipation ²⁾ $T_{\rm S}$ = 120 °C	P _{tot}	50	mW
Operation junction temperature range	T _{jo}	-65 150	°C
Storage junction temperature range	T _{jstg}	-65 150	°C

1) Applicable if VCC and RFOUT are shorted, otherwise a coupling capacitor at RFOUT is demanded

2) $T_{\rm S}$ is measured on the emitter (GND) lead at the soldering point to the pcb

Note: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions even only for a short moment may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Absolute maximum ratings typically differ heavily from recommended operation conditions.

2.2 Thermal Resistance

Table 3Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	≤ 595	K/W

1) For calculation of $R_{\rm thJA}$ please refer to Application Note Thermal Resistance.



3 Electrical Characteristics

Table 4DC characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol V		Values		Unit	Note /
		Min.	Тур.	Max.		Test Condition
Device current	I _{CC}	0.6	0.85	1.1	mA	V _{CC} = 1.2 V

Table 5AC characteristics (measured in test circuit Figure 2; verified by random sampling) $T_A = 25 \,^{\circ}$ C, $V_{CC} = 1.2 \,$ V, $Z_0 = 50 \,$ Ω, unless otherwise specified

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
Insertion power gain	S ₂₁		7.5		dB	<i>F</i> = 0.4 GHz
			7.0			<i>f</i> = 1.8 GHz
Reverse isolation	S ₁₂		-37		dB	<i>F</i> = 0.4 GHz
			-25			<i>f</i> = 1.8 GHz
Noise figure, $Z_{\rm S}$ = $Z_{\rm Sopt}$	NF		1.0		dB	<i>F</i> = 0.4 GHz
			1.6			<i>f</i> = 1.8 GHz
Thid order intercept point at the	OIP ₃		-9		dBm	<i>F</i> = 0.4 GHz,
output ¹⁾						V _{CC} = 1.2 V
			14.5			<i>f</i> = 1.8 GHz,
						$V_{\rm CC}$ = 4 V
1 dB compression point at the output	OP1dB		-19		dBm	<i>F</i> = 0.4 GHz,
						V _{CC} = 1.2 V
			-0.5			<i>f</i> = 1.8 GHz,
						$V_{\rm CC}$ = 4 V
Return loss input	S ₁₁		-0.4		dB	<i>F</i> = 0.4 GHz
			-1.8			<i>f</i> = 1.8 GHz
Return loss output	S ₂₂		-4.0		dB	<i>F</i> = 0.4 GHz
			-6.0			f = 1.8 GHz

1) OIP_3 value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.1 MHz to 6 GHz.



Figure 2 BGR405 test circuit

Data Sheet



Package Information

4 Package Information



Figure 3 Package Outline SOT343



Figure 4 Footprint of SOT343



